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N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V) at T _J max.	650					
R _{DS(on)} max. at 25 °C (Ω)	$V_{GS} = 10 V$	0.7				
Q _g max. (nC)	25					
Q _{gs} (nC)	2.0					
Q _{gd} (nC)	2.7					
Configuration	Single					

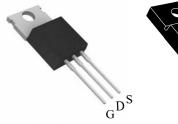
FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

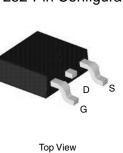
APPLICATIONS

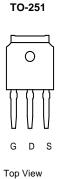
- · Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial

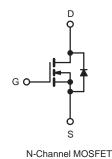
TO-220 Pin Configuration TO-220 FULLPAK **TO-252** Pin Configuration











Top View

ABSOLUTE MAXIMUM RATINGS ($T_C =$					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V _{DS}	650	V		
Gate-Source Voltage	V _{GS}	± 30	- v		
Continuous Drain Current (T _J = 150 °C)	V_{GS} at 10 V $T_C = 25 \degree C$		7	А	
	$V_{GS} \text{ at 10 V} \qquad T_C = 25 \text{ °C}$ $T_C = 100 \text{ °C}$	I _D	6		
Pulsed Drain Current ^a	I _{DM}	10	1		
Linear Derating Factor			1.67/1.5/0.3	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	86	mJ		
Maximum Power Dissipation	P _D	83/83/31	W		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C	a\\//al*	50		
Reverse Diode dV/dt d		dV/dt -	4.5	V/ns	
Soldering Recommendations (Peak Temperature) c	for 10 s	1	300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 3.5 A.

1.6 mm from case. c.

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.





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PARAMETER	SYMBOL	TYP.		MAX.	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		63		°044			
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.6			°C/W			
	place otherw	ico notod)							
SPECIFICATIONS (T _J = 25 °C, u PARAMETER	SYMBOL	1		IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 µA			650	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$		Reference to 25 °C, $I_D = 1$ mA			0.65	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	-	$V_{DS} = V_{GS}, I_D = 250 \mu A$			-	4	V	
		$V_{GS} = \pm 20 V$		-	-	± 100	nA		
Gate-Source Leakage	ource Leakage $I_{GSS} = \frac{V_{GS} - \frac{1}{2000}}{V_{GS} = \pm 3000}$			-	-	± 1	μA		
		-	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$			-	1	<u> </u>	
Zero Gate Voltage Drain Current I_{DSS} $V_{DS} = 520 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	-	10	μA			
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		I _D = 4 A	-	0.7	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D	= 4 A	-	16	-	S	
Dynamic		•			I	1	1	1	
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz $V_{DS} = 0 V to 520 V, V_{GS} = 0 V$		-	360	-	pF		
Output Capacitance	C _{oss}			-	25	-			
Reverse Transfer Capacitance	C _{rss}			-	12	-			
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	45	-			
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	62	-			
Total Gate Charge	Qg	$V_{GS} = 10 \text{ V}$ $I_D = 4 \text{ A}, \text{ V}_{DS} = 520 \text{ V}$		-	25		nC		
Gate-Source Charge	Q _{gs}			-	2.0	-			
Gate-Drain Charge	Q _{gd}			-	2.7	-			
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 520$ V, I _D = 4 A, V _{GS} = 10 V, R _g = 9.1 Ω f = 1 MHz, open drain		-	25	-	- ns		
Rise Time	t _r			-	55	-			
Turn-Off Delay Time	t _{d(off)}			-	70	-			
Fall Time	t _f			-	40	-			
Gate Input Resistance	R _g			-	3.5	-	Ω		
Drain-Source Body Diode Characteristic	S								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	7	- A		
Pulsed Diode Forward Current	I _{SM}			-	-	18			
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 4 A, V _{GS} = 0 V		-	-	1.5	V		
Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 4 \text{ A},$ dl/dt = 100 A/µs, V _R = 400 V		-	190	-	ns		
Reverse Recovery Charge	Q _{rr}			-	2.3	-	μC		
Reverse Recovery Current	I _{RRM}			_	10	-	A		

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

b. Coss(tr) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 % to 80 % VDSS.



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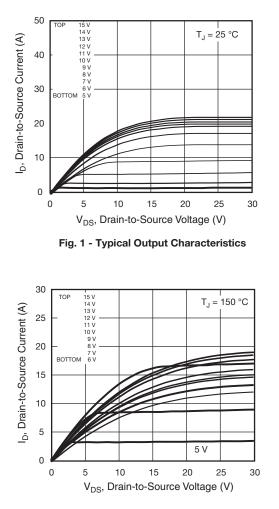


Fig. 2 - Typical Output Characteristics

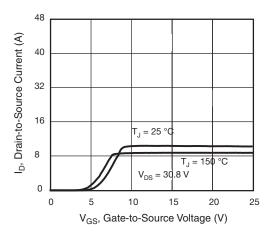


Fig. 3 - Typical Transfer Characteristics

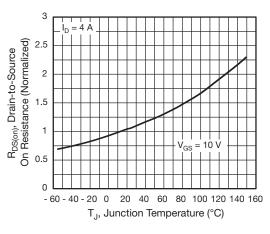


Fig. 4 - Normalized On-Resistance vs. Temperature

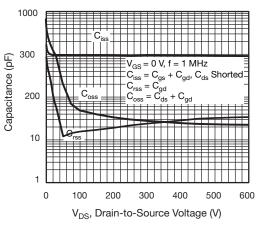


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

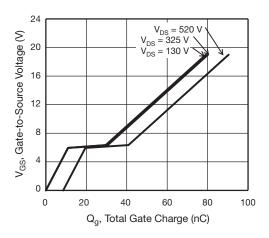


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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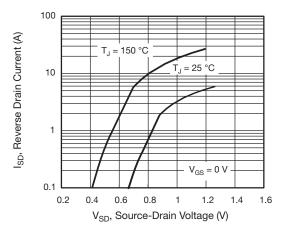


Fig. 7 - Typical Source-Drain Diode Forward Voltage

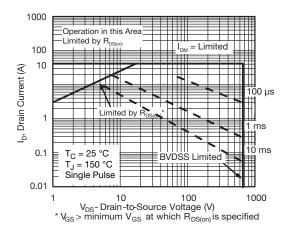


Fig. 8 - Maximum Safe Operating Area

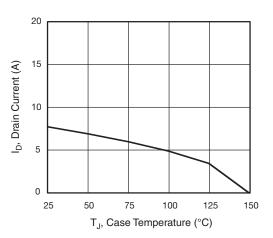


Fig. 9 - Maximum Drain Current vs. Case Temperature

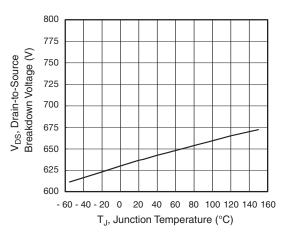


Fig. 10 - Temperature vs. Drain-to-Source Voltage

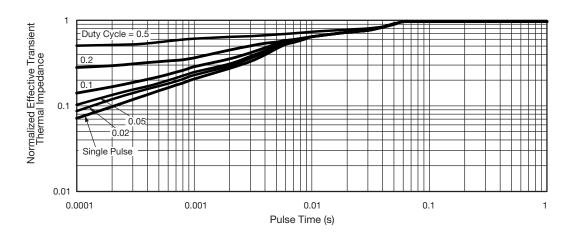


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



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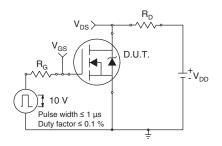


Fig. 12 - Switching Time Test Circuit

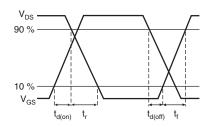


Fig. 13 - Switching Time Waveforms

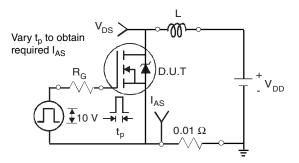


Fig. 14 - Unclamped Inductive Test Circuit

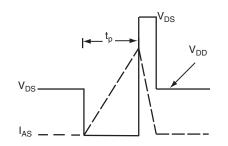


Fig. 15 - Unclamped Inductive Waveforms

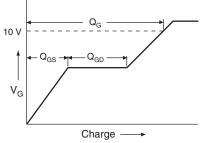


Fig. 16 - Basic Gate Charge Waveform

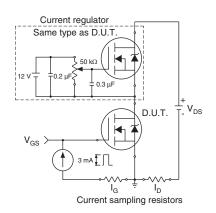
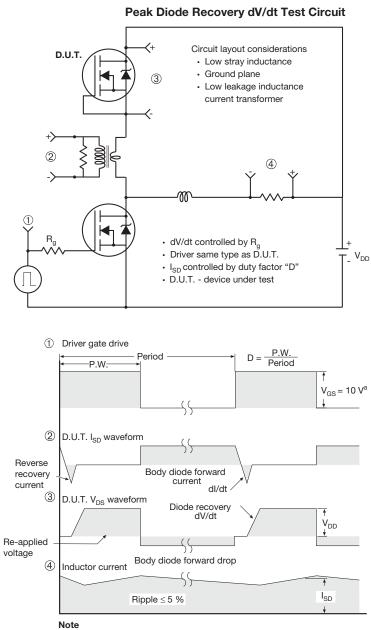


Fig. 17 - Gate Charge Test Circuit



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a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



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